MOSFET - Power, N-Channel

100 V, 19 A, 74 m Ω

Features

- Low R_{DS(on)}
- High Current Capability
- 100% Avalanche Tested
- NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

_				,	
Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	100	V
Gate-to-Source Volta	ge – Conti	nuous	V _{GS}	±20	V
Continuous Drain	Steady T _C = 25°		I _D	19	Α
Current	State	T _C = 100°C]	13	
Power Dissipation	Steady State	T _C = 25°C	P _D	71	W
Pulsed Drain Current	t _p	t _p = 10 μs		70	Α
Operating and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)		IS	19	Α	
Single Pulse Drain-to-Source Avalanche Energy (V _{DD} = 50 Vdc, V _{GS} = 10 Vdc, $I_{L(pk)}$ = 18.2 A, L = 0.3 mH, R_G = 25 Ω)		E _{AS}	50	mJ	
Lead Temperature for Purposes, 1/8" from C		Seconds	T _L	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Case (Drain) - Steady State	$R_{\theta JC}$	2.1	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	47	

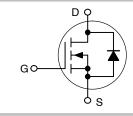
1. Surface mounted on FR4 board using 1 sq in pad size, (Cu Area 1.127 sq in [2 oz] including traces).



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V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
100 V	74 mΩ @ 10 V	19 A



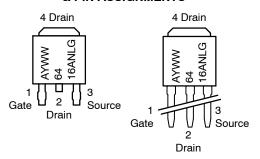


DPAK CASE 369AA STYLE 2



IPAK CASE 369D STYLE 2

MARKING DIAGRAM & PIN ASSIGNMENTS



A = Assembly Location*

Y = Year

WW = Work Week
6416ANL = Device Code
G = Pb-Free Package

* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

ORDERING INFORMATION

See detailed ordering and shipping information on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition	on	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•						
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 2$	50 μA	100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				120		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 100 V	$T_{J} = 25^{\circ}C$ $T_{J} = 125^{\circ}C$			1.0	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} =	Ŭ			±100	nA
ON CHARACTERISTICS (Note 2)	400	D0 / G0	L				
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 2$	250 սA	1.0		2.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J	de Berb			5.4		mV/°C
Drain-to-Source On-Resistance	R _{DS(on)}	V _{GS} = 4.5 V, I _D =	= 10 A		70	80	mΩ
		V _{GS} = 10 V, I _D =	10 A		62	74	1
		V _{GS} = 10 V, I _D =	19 A		68	74	1
Forward Transconductance	9 _{FS}	V _{DS} = 5 V, I _D = 10 A			18		S
CHARGES, CAPACITANCES AND GA	TE RESISTAN	ICE	•		•		
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 25 V			700	1000	pF
Output Capacitance	Coss				110		
Reverse Transfer Capacitance	C _{RSS}				50		
Total Gate Charge	Q _{G(TOT)}				25	40	nC
Threshold Gate Charge	Q _{G(TH)}		•		0.7		1
Gate-to-Source Charge	Q_{GS}	V _{GS} = 10 V, V _{DS} = 80	V, I _D = 19 A		2.4		
Gate-to-Drain Charge	Q_{GD}		•		9.6		
Plateau Voltage	V_{GP}		•		3.2		V
Gate Resistance	R_{G}				2.4		Ω
SWITCHING CHARACTERISTICS (No	te 3)	-			-		-
Turn-On Delay Time	t _{d(on)}				7.0		ns
Rise Time	t _r	V _{GS} = 10 V, V _{DD}	= 80 V,		16		
Turn-Off Delay Time	t _{d(off)}	$I_D = 19 \text{ A}, R_G = 10 \text{ A}$	6.1 Ω		35		
Fall Time	t _f		•		40		
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V, I _S = 19 A	$T_{J} = 25^{\circ}C$ $T_{J} = 125^{\circ}C$		0.9 0.72	1.2	V
Reverse Recovery Time	t _{RR}		J 3		50		ns
Charge Time	T _a	V 0V 41 741	100 1/		38		
Discharge Time	T _b	$V_{GS} = 0 \text{ V, dI}_{S}/\text{dt} = 0 \text{ I}_{S} = 19 \text{ A}$	ιυυ A/μs,		14		1
Reverse Recovery Charge	Q _{RR}	-			112		nC
	•	ctrical Characteristics for the listed test			<u> </u>		<u> </u>

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

2. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2%.

3. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

ID, DRAIN CURRENT (A)

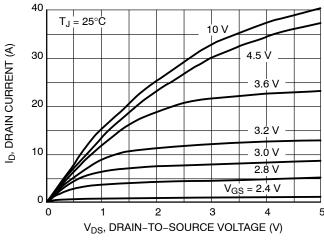


Figure 1. On-Region Characteristics

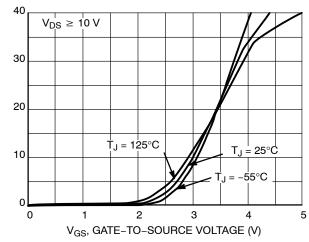


Figure 2. Transfer Characteristics

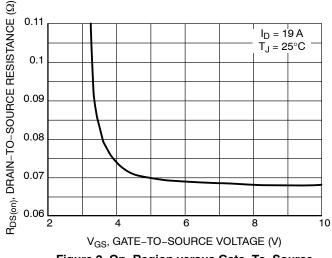


Figure 3. On-Region versus Gate-To-Source Voltage

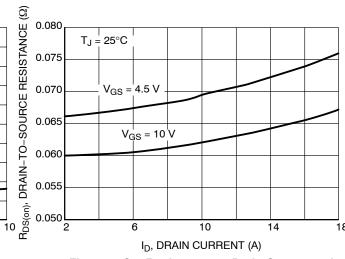


Figure 4. On-Region versus Drain Current and Gate-To-Source Voltage

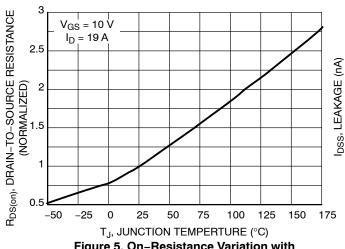


Figure 5. On–Resistance Variation with Temperature

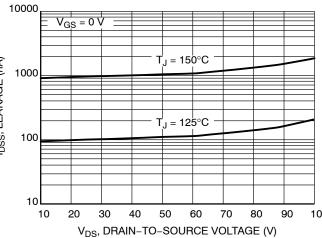
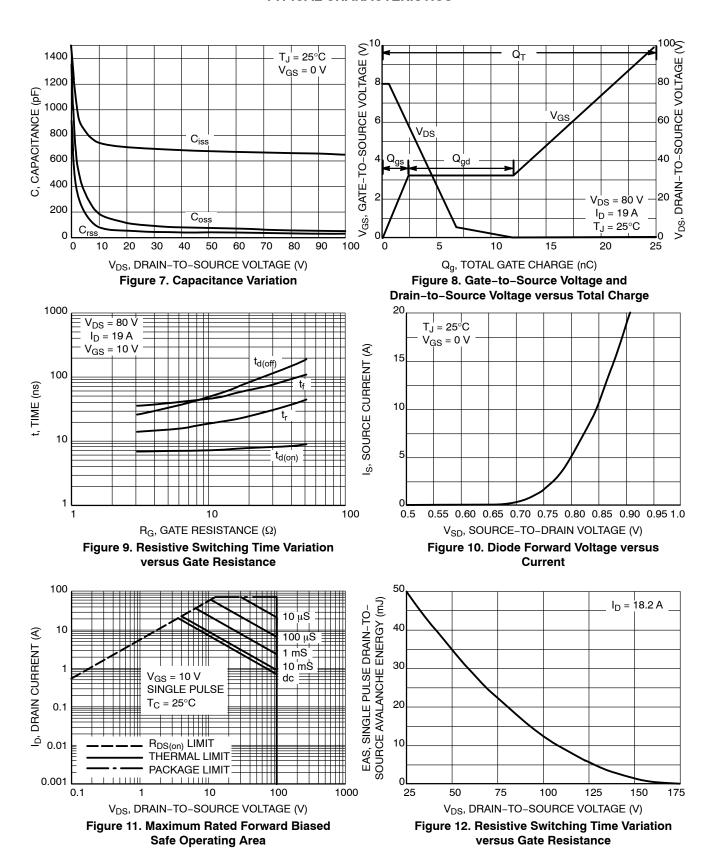


Figure 6. Drian-to-Source Leakage Current versus Voltage

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

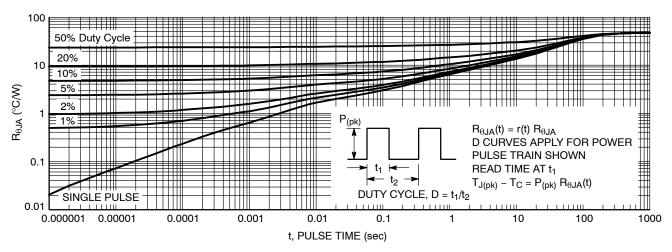


Figure 13. Thermal Response (NTD6416ANL DPAK PCB Cu Area 720 mm² PCB Cu thk 2 oz)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTD6416ANLT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NTD6416ANL-1G	IPAK (Pb-Free)	75 Units / Rail
NVD6416ANLT4G*	DPAK (Pb-Free)	2500 / Tape & Reel
NVD6416ANLT4G-VF01*	DPAK (Pb-Free)	2500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

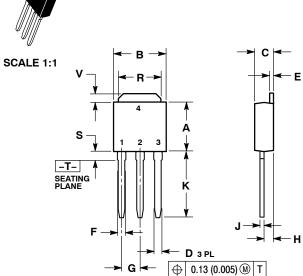
^{*}NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable.

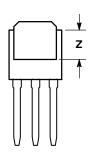
MECHANICAL CASE OUTLINE





DATE 15 DEC 2010





- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	BSC	2.29	BSC
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

grated rcuits XXXX YWW

ocation.

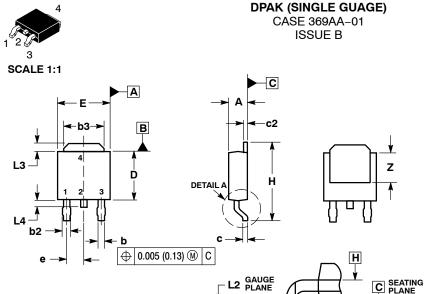
= Year WW = Work Week

				MARKING DIAGRAMS
STYLE 1: PIN 1. BASE 2. COLLECTOR 3. EMITTER 4. COLLECTOR	STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN	STYLE 3: PIN 1. ANODE 2. CATHODE 3. ANODE 4. CATHODE	STYLE 4: PIN 1. CATHODE 2. ANODE 3. GATE 4. ANODE	Discrete Circ
STYLE 5: PIN 1. GATE 2. ANODE 3. CATHODE 4. ANODE	STYLE 6: PIN 1. MT1 2. MT2 3. GATE 4. MT2	STYLE 7: PIN 1. GATE 2. COLLECTOR 3. EMITTER 4. COLLECTOR		YWW ALY
				xxxxxxxxx = Device Code A = Assembly Lo

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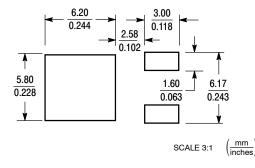
4. ANODE



DETAIL A ROTATED 90° CW STYLE 4: PIN 1. CATHODE 2. ANODE 3. GATE STYLE 1: PIN 1. BASE STYLE 2: PIN 1. GATE STYLE 3: PIN 1. ANODE 2. COLLECTOR 3. EMITTER 2. CATHODE 3. ANODE 2. DRAIN 3. SOURCE 4. COLLECTOR 4. DRAIN CATHODE STYLE 5: STYLE 6: STYLE 7: PIN 1. GATE 2. ANODE 3. CATHODE PIN 1. GATE 2. COLLECTOR PIN 1. MT1 2. MT2 3. GATE 3. EMITTER

COLLECTOR

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

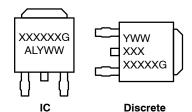
DATE 03 JUN 2010

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: INCHES.
 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-
- MENSIONS b3, L3 and Z.
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H

	INC	INCHES		IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29	BSC
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108	REF	2.74	REF
L2	0.020	BSC	0.51	BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

GENERIC MARKING DIAGRAM*



XXXXXX = Device Code Α = Assembly Location L = Wafer Lot ٧ = Year = Work Week WW = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking.

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DESCRIPTION:	DPAK (SINGLE GAUGE)		PAGE 1 OF 1	

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